

<b>Notice of References Cited</b>	Application/Control No. 10/558,090		Applicant(s)/Patent Under Reexamination PINEDA DE GYVEZ ET AL.	
	Examiner Ji H. Bae		Art Unit 2115	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,498,988	03-1996	Reyes et al.	327/199
*	B	US-5,339,445	08-1994	Gasztanyi, Laszlo R.	713/324
*	C	US-2004/0225902	11-2004	Cesare et al.	713/300
*	D	US-6,212,641	04-2001	Frank et al.	713/323
*	E	US-6,101,609	08-2000	Kawasaka, Yasuki	713/322
*	F	US-5,954,820	09-1999	Hetzler, Steven Robert	713/323
*	G	US-5,719,800	02-1998	Mittal et al.	713/321
*	H	US-2006/0119991	06-2006	Garg et al.	361/018
*	I	US-5,667,537	09-1997	Richiardone et al.	29/623.2
*	J	US-5,781,783	07-1998	Gunther et al.	713/320
*	K	US-6,307,281	10-2001	Houston, Theodore W.	307/31
*	L	US-5,457,790	10-1995	Iwamura et al.	711/167
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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